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Electronic Components Industry Association (ECIA)
1111 Alderman Drive, Suite 400
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Phone: (678) 393-9990
Fax: (678) 393-9998

rwillis@eciaonline.org

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TABLE OF CONTENTS

Hermetically Sealed 230C MnO₂ Tantalum Capacitors.....	1
<i>T. Zedniecek, M. Biler, J. Petrik, I. Pinwill</i>	
High Temperature Ta/MnO₂ Capacitors.....	9
<i>Y. Freeman, A. Chacko, P. Lessner, S. Hussey, R. Marques, J. Moncada</i>	
Energy Storage Systems Based on Vacuum Diffusion Doping Method for Ferroelectric Ceramics.....	14
<i>Sergey N. Ryazantsev, Igor V. Shcherbakov</i>	
Novel Ceramic and Metal Materials for Energy Storage and Clean Tech Applications	27
<i>Brian C. Foster, Gordon Dayton</i>	
Development of Ultrathin Ultracapacitors for Enhanced Lithium Batteries in Portable Electronic Applications.....	38
<i>E. R. Buiel, D. Rich, B. P. Gridley, S. Mehta</i>	
Solid State Polymer-multi-layer (PML) Capacitors.....	46
<i>Angelo Yiallizis, Yuji Ozaki</i>	
Increasing Resistor Network Density while Maintaining Electrical Performance Characteristics	56
<i>Akhlaq Rahman, Fred Olinger, Jim Norman, Wend Ouedraogo, Michael Howieson</i>	
High Temperature Ceramic Capacitors for Deep Well Applications.....	62
<i>Reggie Phillips, John Bultitude, Abhijit Gurav, Kitae Park, Sergio Murillo, Pamela Flores, Mark Laps</i>	
High Operating Temperature Baseplate in Space Applications	71
<i>Denis Lacombe</i>	
Thin Film/Thick Chip Resistor Behavior Depending on Substrate, Resistive Element Used at Temperatures up to 270°C	80
<i>Dominique Vignolo, Vishay Sfernice</i>	
KEMET Film Capacitors for High Temperature, High Voltage and High Current	92
<i>Luca Caliari, Paola Bettacchi, Evangelista Boni, Davide Montanari, Arrigo Gamberini, Luigi Barbieri, Francesco Bergamaschi</i>	
ESD-Safe™ MLCCs & Multilayer Varistors: A Qualitative & Quantitative Comparison	108
<i>Ron Demcko, Michael Kirk, Edgardo Menendez</i>	
Smallest and Lowest Profile Tantalum Capacitors.....	117
<i>T. Zedniecek, I. Paukert, Zednickova</i>	
Should Base Metal Electrode (BME) Ceramic Capacitors Be Accepted for High Reliability Space Usage?.....	126
<i>M. J. Cozzolino</i>	
Failure Analysis of Dielectric Breakdowns in Base-Metal Electrode Multilayer Ceramic Capacitors	137
<i>Ronald J. Weachock, David Liu</i>	
Dendrite Growth in BME and PME Ceramic Capacitors.....	156
<i>Jaemi Herzberger, Alexander Teverovsky</i>	
Considerations for Base-Metal Electrode (BME) Ceramic Capacitors for High Reliability Applications.....	181
<i>Abhijit Gurav, Craig Scruggs, Richard Turner, Travis Ashburn</i>	
Component Interconnect Failure: Latent Cracking of Tantalum - Titanium Welds Due to Hydrogen Embrittlement.....	191
<i>Joachim Hossick-Schott, Markus Reiterer, Jason Heffelfinger, Mike Hintz, Mike Ringle, Iryna Levina, Kevin Gaffney</i>	
Lifetime Evaluation under Operating Condition for MLCC by Highly Accelerated Life Test	197
<i>Akihiro Shiota, Toshimi Oguni, Tomoyuki Nakamura, Makoto Matsuda, Hiroyuki Wada, Harunobu Sano</i>	
Understanding High Voltage Corona Tests.....	207
<i>Paul Cossaboon</i>	
Highly Accelerated Life Stress Testing (HALST) of Base-Metal Electrode Multilayer Ceramic Capacitors	217
<i>David Liu</i>	
The Electron Conduction Mechanism in Hermetically Sealed SMD Tantalum Capacitors.....	235
<i>J. Sukula, V. Sedlakova, J. Petrik, M. Biler, T. Zedniecek</i>	
High Voltage Multi-Layer Ceramic Capacitors for Use at High Temperatures	244
<i>Jim Magee, John Bultitude, Lonnie Jones, Mark Laps, Javier Zavala, Ana Garza, Glenda Torres, Wanda Andrews, Abhijit Gurav, Corey Antoniades, Reggie Phillips</i>	
Reaching the Highest Reliability for Tantalum Capacitors	256
<i>James Bates, Marc Beaulieu, Michael Miller, Joseph Paulus</i>	

Nanomaterials Commercialization and Passive Applications	268
<i>Alan Rae</i>	
RoHS Compliant Very Low Fired High-K (K~100) COG dielectric for Air Fired Multilayer Ceramic Capacitors	275
<i>Anton V. Polotai, Samir G. Maher, James M. Wilson, Riad G. Maher</i>	
Selective Coating of Ceramic Capacitors and its Applications for High Voltage X7R MLCC	286
<i>Frank Wei</i>	
Author Index	